

Sheet 1 of 1 ATTORNEY DOCKET NO. FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE 09/938,496 1614,1181 FIRST NAMED INVENTOR INFORMATION DISCLOSURE STATEMENT Hideo MIYAKE et al. GROUP ART UNIT FILING DATE (Use several sheets if necessary) August 27, 2001 2112 2155 **U.S. PATENT DOCUMENTS** EXAMINER DOCUMENT SUB-FILING INITIAL NO. CLASS CLASS DATE DATE NAME AA AB AC AD AE AF FOREIGN PATENT DOCUMENTS DOCUMENT **ABSTRACT** NO. COUNTRY **TRANSLATION** DATE YES NO KB AG 2000-0024937 05-06-2000 Korea Χ Χ AH ΑI AJ ΑK AL TRANSLATION OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) YES NO AM DATE CONSIDERED **EXAMINER**

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Sheet 1 of 1 ATTORNEY DOCKET NO. **FORM PTO-1449** U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE 09/938,496 1614.1181 FIRST NAMED INVENTOR INFORMATION DISCLOSURE STATEMENT Hideo MIYAKE et al. FILING DATE GROUP ART UNIT (Use several sheets if necessary) August 27, 2001 2155 **U.S. PATENT DOCUMENTS** EXAMINER DOCUMENT SUB-FILING INITIAL NO. **CLASS** DATE **CLASS** DATE NAME AA AB AC AD AE AF FOREIGN PATENT DOCUMENTS DOCUMENT **ABSTRACT** NO. DATE COUNTRY **TRANSLATION** YES 07-006038 KB 01/10/1995 AG Japan X Yes AH ΑI AK ΑL TRANSLATION OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) AM **EXAMINER** DATE CONSIDERED

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ATTACHMENT 1(g)

LIST OF ADDITIONAL SUBMITTED DOCUMENTS

ATTORNEY DOCKET NO.	APPLICATION NO.
1614.1181	09/938,496
FIRST NAMED INVENTOR	
Hideo MIYAKE et al.	
FILING DATE	GROUP ART UNIT
August 27, 2001	2155

The following document(s) is/are listed in accordance with the duty of disclosure provisions of 37 CFR § 1.56, so that the Examiner may consider same should he deem any thereof to be material to examination of the subject application.

It is requested that the Examiner acknowledge his consideration of document(s) below-listed by initialling same in the space provided adjacent each such application and that the Examiner sign and date this form at the bottom thereof to confirm such consideration having been given.

This submission in no way represents an admission that any of the information listed herein constitutes prior art with respect to the subject application; and unless and until such prior art status is established, this submission is not a request that the information presented herein be printed on the face of any patent issuing from the subject application in which this information is being filed.

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	AB						

FOREIGN PATENT DOCUMENTS

	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSL YES	ATION NO
AC	÷						
AD							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)				
	AE	Japanese Patent Office Action, mailed February 6, 2007, and issued in priority Japanese Patent Application No. 2000-386032		х

EXAMINER OL + BT	DATE CONSIDERED 6/7/07				
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citation if not in conformance and not considered. Include copy of	tinis form with next communication to applicant.				